

Notice of References Cited	Application/Control No. 10/762,111		Applicant(s)/Patent Under Reexamination TEUSCHLER ET AL.	
	Examiner Tuan H. Nguyen		Art Unit 2813	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0031890	02-2003	Moriya et al.	428/620
	B	US-			
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	E	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1049145 A1	11-2000	European Patent	KATO et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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